

# **MOSMIC**<sup>®</sup> for TV–Tuner Prestage with 12 V Supply Voltage

MOSMIC - MOS Monolithic Integrated Circuit

#### Electrostatic sensitive device. Observe precautions for handling.



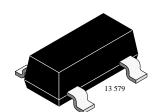
#### **Applications**

Low noise gain controlled input stages in UHF-and VHF- tuner with 12 V supply voltage.

# $\begin{array}{c|c} C \ block \\ \hline \\ AGC \bigcirc \\ \hline \\ RF \ in \\ \hline \\ C \ block \\ \end{array} \begin{array}{c|c} RFC \\ \hline \\ VDD \\ \hline \\ RF \ out \\ \hline \\ C \ block \\ \end{array}$

#### **Features**

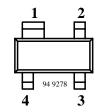
- Integrated gate protection diodes
- Low noise figure
- High gain
- Biasing network on chip

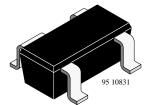


S886T Marking: 982 Plastic case (SOT 143)

1 = Source, 2 = Drain, 3 = Gate 2, 4 = Gate 1

- Improved cross modulation at gain reduction
- High AGC-range
- SMD package





S886TR Marking: 82R Plastic case (SOT 143R)

1 = Source, 2 = Drain, 3 = Gate 2, 4 = Gate 1

#### **Absolute Maximum Ratings**

T<sub>amb</sub> = 25°C, unless otherwise specified

Parameter	Test Conditions	Symbol	Value	Unit
Drain - source voltage		V <sub>DS</sub>	16	V
Drain current		I <sub>D</sub>	30	mA
Gate 1/Gate 2 - source peak current		±I <sub>G1/G2SM</sub>	10	mA
Gate 1/Gate 2 - source voltage		±V <sub>G1/G2SM</sub>	7.5	V
Total power dissipation	T <sub>amb</sub> ≤ 60 °C	P <sub>tot</sub>	200	mW
Channel temperature		T <sub>Ch</sub>	150	°C
Storage temperature range		T <sub>stq</sub>	-55 to +150	°C

#### **Maximum Thermal Resistance**

T<sub>amb</sub> = 25°C, unless otherwise specified

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Parameter	Test Conditions	Symbol	Value	Unit
Channel ambient	on glass fibre printed board (25 x 20 x 1.5) mm <sup>3</sup> plated with 35µm Cu	R <sub>thChA</sub>	450	K/W

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#### S886T/S886TR

#### Vishay Telefunken



#### **Electrical DC Characteristics**

T<sub>amb</sub> = 25°C, unless otherwise specified

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
Gate 1 - source breakdown voltage	$\pm I_{G1S} = 10 \text{ mA}, V_{G2S} = V_{DS} = 0$	±V <sub>(BR)G1SS</sub>	8		12	V
Gate 2 - source breakdown voltage	$\pm I_{G2S} = 10 \text{ mA}, V_{G1S} = V_{DS} = 0$	±V <sub>(BR)G2SS</sub>	8		12	V
Gate 1 - source	$+V_{G1S} = 6 \text{ V}, V_{G2S} = V_{DS} = 0$	+I <sub>G1SS</sub>			60	μΑ
leakage current	$-V_{G1S} = 6 \text{ V}, V_{G2S} = V_{DS} = 0$	-I <sub>G1SS</sub>			120	μΑ
Gate 2 - source leakage current	$\pm V_{G2S} = 6 \text{ V}, \ V_{G1S} = V_{DS} = 0$	±I <sub>G2SS</sub>			20	nA
Drain current	$V_{DS} = 12 \text{ V}, V_{G1S} = 0, V_{G2S} = 6 \text{ V}$	I <sub>DSS</sub>	50		500	μΑ
Self-biased operating current	$V_{DS} = 12 \text{ V}, V_{G1S} = \text{nc}, V_{G2S} = 6 \text{ V}$	I <sub>DSP</sub>	8	12	16	mA
Gate 2 - source cut-off voltage	$V_{DS} = 12 \text{ V}, V_{G1S} = \text{nc}, I_D = 200 \mu\text{A}$	V <sub>G2S(OFF)</sub>		1.0		V

#### **Electrical AC Characteristics**

 $V_{DS}$  = 12 V,  $V_{G2S}$  = 6 V, f = 1 MHz ,  $T_{amb}$  = 25°C, unless otherwise specified

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
Forward transadmittance		y <sub>21s</sub>	25	30	35	mS
Gate 1 input capacitance		C <sub>issg1</sub>		2.3	2.7	pF
Feedback capacitance		C <sub>rss</sub>		20		fF
Output capacitance		Coss		0.9		pF
Power gain	$G_S = 2 \text{ mS}, G_L = 0.5 \text{ mS}, f = 200 \text{ MHz}$	G <sub>ps</sub>		27		dB
	$G_S = 3.3 \text{ mS}, G_L = 1 \text{ mS}, f = 800 \text{ MHz}$	G <sub>ps</sub>	17.5	22		dB
AGC range	$V_{DS} = 12 \text{ V}, V_{G2S} = 1 \text{ to 6 V}, f = 800 \text{ MHz}$	$\Delta G_{ps}$	45			dB
Noise figure	$G_S = 2 \text{ mS}, G_L = 0.5 \text{ mS}, f = 200 \text{ MHz}$	F		1		dB
	$G_S = 3.3 \text{ mS}, G_L = 1 \text{ mS}, f = 800 \text{ MHz}$	F		1.3	·	dB

#### Caution for Gate 1 switch-off mode:

No external DC-voltage on Gate 1 in active mode! Switch-off at Gate 1 with  $V_{G1S}$  < 0.7 V is feasible.

Using open collector switching transistor (inside of PLL), insert 10 k $\Omega$  collector resistor.



#### **Common Source S-Parameters**

 $V_{DS}$  = 12 V ,  $V_{G2S}$  = 6 V ,  $~Z_0$  = 50  $\Omega, T_{amb}$  = 25  $^{\circ}C,~unless$  otherwise specified

	S1	11	S2	21	S1	2	S2	S22	
f/MHz	LOG MAG	ANG	LOG MAG	ANG	LOG MAG	ANG	LOG MAG	ANG	
	dB	deg	dB	deg	dB	deg	dB	deg	
50	-0.02	-4.8	10.29	174.4	-61.79	87.6	-0.35	-1.9	
100	-0.05	-9.3	10.20	168.1	-55.74	84.8	-0.38	-3.7	
150	-0.14	-13.8	10.10	161.6	-52.32	81.5	-0.40	-5.5	
200	-0.23	-18.2	9.97	155.4	-50.05	79.2	-0.43	-7.3	
250	-0.35	-22.5	9.78	148.7	-48.45	76.3	-0.45	-9.1	
300	-0.48	-26.6	9.64	143.2	-47.20	74.5	-0.47	-10.5	
350	-0.63	-30.8	9.40	137.5	-46.23	72.5	-0.51	-12.2	
400	-0.80	-34.7	9.24	132.0	-45.57	71.2	-0.55	-13.8	
450	-0.95	-38.4	8.95	126.1	-45.19	69.4	-0.60	-15.3	
500	-1.15	-42.2	8.74	121.1	-44.92	68.7	-0.63	-17.1	
550	-1.31	-45.7	8.54	116.4	-44.76	69.0	-0.67	-18.4	
600	-1.46	-49.3	8.31	111.2	-44.58	70.8	-0.69	-19.9	
650	-1.62	<del></del> 52.4	8.07	106.6	-44.57	72.3	-0.72	-21.6	
700	-1.81	-56.0	7.85	101.9	-44.75	73.4	-0.75	-22.7	
750	-1.95	-58.9	7.67	97.3	-45.03	76.3	-0.77	-24.6	
800	-2.11	-62.0	7.47	92.7	-45.27	81.0	-0.79	-25.8	
850	-2.26	-65.3	7.28	87.8	-45.52	86.6	-0.81	-27.5	
900	-2.37	-68.2	7.08	83.3	-45.41	94.9	-0.83	-29.1	
950	-2.49	-71.5	6.94	79.3	-44.79	103.7	-0.85	-31.0	
1000	-2.62	-74.5	6.71	74.6	-44.21	107.4	-0.87	-32.3	
1050	-2.76	<del>-</del> 77.5	6.62	70.9	-43.95	113.3	-0.89	-33.9	
1100	-2.90	-80.2	6.44	66.0	-43.64	120.8	-0.90	-35.3	
1150	-2.98	-83.2	6.34	62.2	-42.73	128.9	-0.87	-37.2	
1200	-3.07	-86.0	6.17	57.3	-41.82	135.7	-0.85	-38.8	
1250	-3.14	-88.8	6.11	53.6	-40.68	142.1	-0.80	-40.4	
1300	-3.24	-91.6	6.00	48.8	-39.80	146.1	-0.76	-42.4	



#### **Typical Characteristics** $(T_{amb} = 25^{\circ}C \text{ unless otherwise specified})$

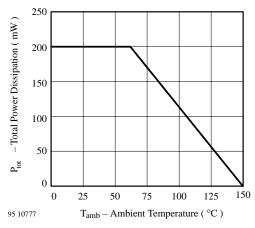


Figure 1. Total Power Dissipation vs. Ambient Temperature

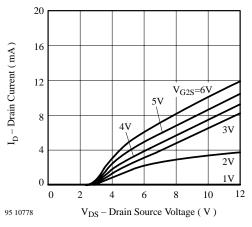


Figure 2. Drain Current vs. Drain Source Voltage

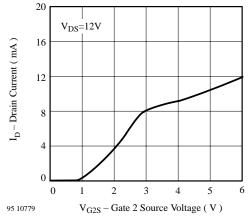


Figure 3. Drain Current vs. Gate 2 Source Voltage

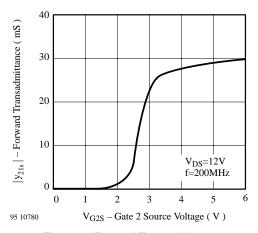


Figure 4. Forward Transadmittance vs. Gate 2 Source Voltage

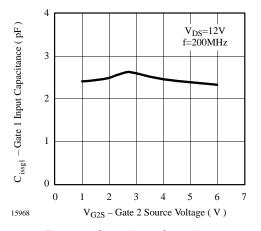


Figure 5. Gate 1 Input Capacitance vs. Gate 2 Source Voltage

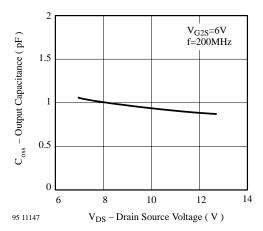


Figure 6. Output Capacitance vs. Drain Source Voltage





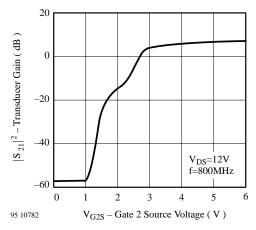


Figure 7. Transducer Gain vs. Gate 2 Source Voltage

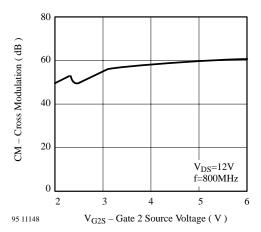


Figure 8. Cross Modulation vs. Gate 2 Source Voltage

 $V_{DS}$  = 12 V,  $V_{G2S}$  = 6 V ,  $Z_0$  = 50  $\Omega$ 

# S<sub>11</sub>

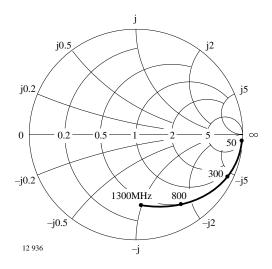


Figure 9. Input reflection coefficient

#### S<sub>21</sub>

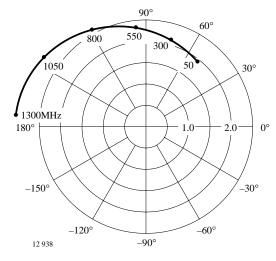


Figure 10. Forward transmission coefficient

# S<sub>12</sub>

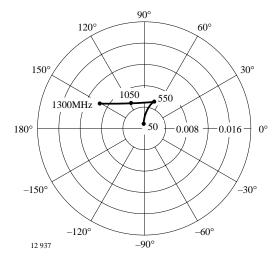


Figure 11. Reverse transmission coefficient

# S<sub>22</sub>

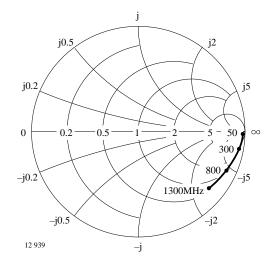
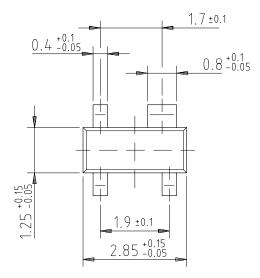
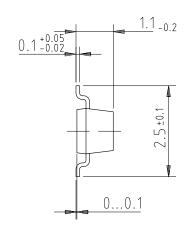


Figure 12. Output reflection coefficient

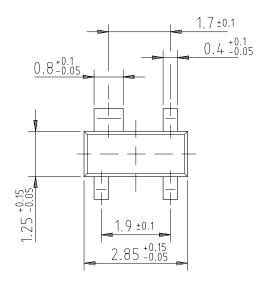
#### **Dimensions of S886T in mm**

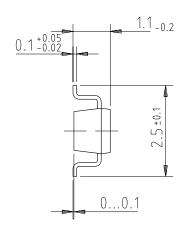


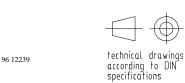




#### **Dimensions of S886TR in mm**







#### S886T/S886TR

#### Vishay Telefunken



#### **Ozone Depleting Substances Policy Statement**

It is the policy of Vishay Semiconductor GmbH to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

**Vishay Semiconductor GmbH** has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice. Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use Vishay-Telefunken products for any unintended or unauthorized application, the buyer shall indemnify Vishay-Telefunken against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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